

Excellent Integrated System Limited

Stocking Distributor

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Infineon Technologies SIDC03D60F6

For any questions, you can email us directly: sales@integrated-circuit.com





SIDC03D60F6

Fast switching diode

Features:

- 600V Emitter Controlled technology 70 μm
 chip
- · soft , fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

 power modules and discrete devices



Applications:

SMPS, resonant applications, drives

Chip Type	V_{R}	I F	Die Size	Package
SIDC03D60F6	600V	6A	1.2 x 2.25 mm ²	sawn on foil

Mechanical Parameters

1.2 x 2.25		
2.7	mm ²	
0.718 x 1.768		
70	μm	
150	mm	
5650		
Photoimide		
3200 nm AlSiCu		
Ni Ag –system suitable for epoxy and soft solder die bonding		
Electrically conductive glue or solder		
Al, ≤250μm		
Ø 0.65mm; max 1.2mm		
Store in original container, in dry nitrogen, in dark environment, < 6 month at an ambient temperature of 23°C		
	2.7 0.718 x 1.768 70 150 5650 Photoimide 3200 nm AlSiCu Ni Ag –system suitable for epoxy and soft solder die bond Electrically conductive glue or solder Al, ≤250µm Ø 0.65mm; max 1.2mm Store in original container, in dry nitrogen, in	

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Datasheet of SIDC03D60F6 - DIODE GEN PURP 600V 6A WAFER

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SIDC03D60F6

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}	T _{vj} = 25 °C	600	V
Continuous forward current	I _F	<i>T</i> _{vj} < 150°C	1)	
Maximum repetitive forward current	I _{FRM}	<i>T</i> _{vj} < 150°C	12	- A
Junction temperature range	T_{vj}		-40+175	°C
Operating junction temperature	T _{vj}		-40+150	°C
Dynamic ruggedness ²⁾	P _{max}	$I_{\text{Fmax}} = 12\text{A}, \ V_{\text{Rmax}} = 600\text{V}, \ T_{\text{vj}} \le 150^{\circ}\text{C}$	tbd	kW

¹⁾ depending on thermal properties of assembly

Static Characteristic (tested on wafer), $T_{vj} = 25 \,^{\circ}\text{C}$

Parameter	Symbol	Conditions	Value			Unit
raiailletei	Syllibol	Conditions	min.	typ.	max.] 01111
Reverse leakage current	I_{R}	V _R =600V			27	μA
Cathode-Anode breakdown Voltage	V_{BR}	I _R =0.5mA	600			V
Diode forward voltage	V _F	I _F =6A		1.6		V

Further Electrical Characteristics

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

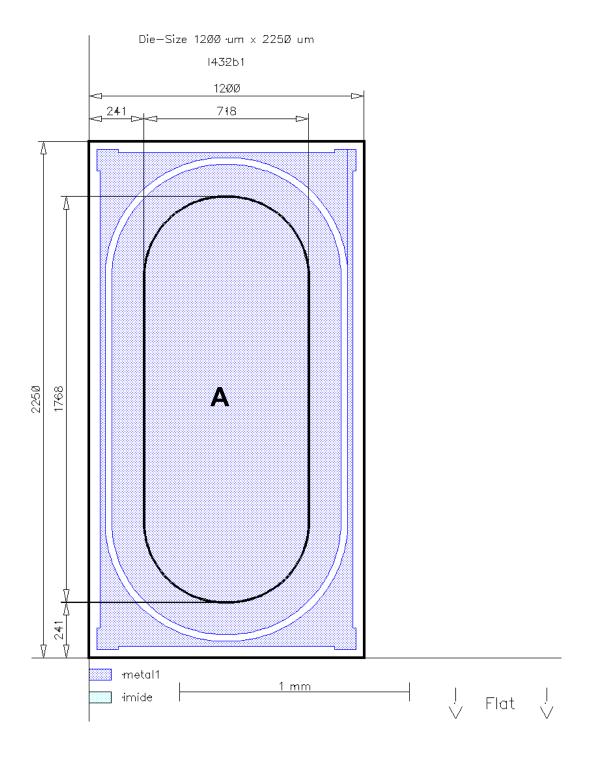
²⁾ not subject to production test - verified by design/characterisation





SIDC03D60F6

Chip Drawing



A: Anode pad



Description

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AQL 0,65 for \	isual inspection according to failure catalogue	
Electrostatic D	ischarge Sensitive Device according to MIL-STD 883	
Revision Hist	ory	
Version	Subjects (major changes since last revision)	Date

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